

Features

- Effectively lower down T_j and R_{th} , high anti-EMI ability
- High speed switching with low capacitances
- High blocking voltage with low $R_{DS(on)}$
- Easy to drive and parallel
- RoHS compliant

Benefits

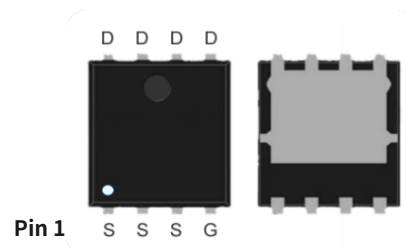
- Increased power density
- Higher operating frequency
- Reduced heat sink requirements
- Higher efficiency
- EMI reduction

Applications

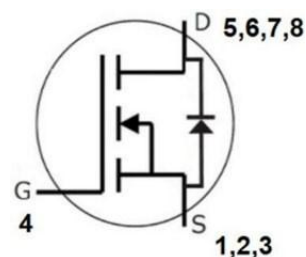
- Power factor correction modules
- Switch mode power supplies
- Power inverters
- High voltage converters

Part Number	Package	Marking
GC3M026065P	PDFN 5×6	GC3M026065

Parameter	Rating	Units
V_{DS}	800	V
$I_D @ 25^\circ\text{C}$	15	A
$R_{DS(on)}$	260	mΩ



PDFN 5×6 Package



Maximum Ratings ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit
V_{DS}	Drain-Source Voltage	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	800	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$	15 12	A
I_{DM}	Peak Drain Current	Pulse width t_p limited by T_{jmax}	39	A
$V_{GS\text{ max}}$	Gate-Source Voltage		-5/ 26	V
$V_{GS\text{ op}}$	Recommend Gate-Source Voltage		0/ 18	V
P_{tot}	Power Dissipation	$T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$	52 25	W
T_j	Operating Junction Temperature		-55~175	$^\circ\text{C}$
T_{stg}	Storage Temperature		-55~175	$^\circ\text{C}$

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	800			V	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	15	μA	$V_{GS} = 0\text{ V}, V_{DS} = 850\text{ V}$	
I_{GSS}	Gate-Source Leakage Current			50	nA	$V_{DS} = 0\text{ V}, V_{GS} = 18\text{ V}$	
$V_{GS(th)}$	Gate Threshold Voltage		3.5	4.0	V	$V_{GS} = V_{DS}, I_{DS} = 1\text{ mA}, T_J = 25^\circ\text{C}$	Fig. 14
			2.8			$V_{GS} = V_{DS}, I_{DS} = 1\text{ mA}, T_J = 175^\circ\text{C}$	
$R_{DS(on)}$	Static Drain-Source On-Resistance		260 180	300 220	m Ω	$V_{GS} = 15\text{ V}, I_D = 4.5\text{ A}, T_J = 25^\circ\text{C}$ $V_{GS} = 18\text{ V}, I_D = 4.5\text{ A}, T_J = 25^\circ\text{C}$	Fig. 15
			295 205			$V_{GS} = 15\text{ V}, I_D = 4.5\text{ A}, T_J = 175^\circ\text{C}$ $V_{GS} = 18\text{ V}, I_D = 4.5\text{ A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		180		pF	$V_{DS} = 400\text{ V}, f = 1\text{ MHz}, V_{GS} = 0\text{ V}$	Fig. 8
C_{oss}	Output Capacitance		20				
C_{rss}	Reverse Transfer Capacitance		0.9				
Q_{gs}	Gate-Source Charge		2.3		nC	$V_{DD} = 400\text{ V}, I_D = 5\text{ A}, R_G = 10\text{ }\Omega, V_{GS} = 0/15\text{ V}$	Fig. 7
Q_{gd}	Gate-Drain Charge		1.1				
Q_g	Total Gate Charge		11.2				
E_{on}	Turn-On Switching Energy		25				
E_{off}	Turn-Off Switching Energy		10		μJ		Fig. 12
$t_{d(on)}$	Turn-On Delay Time		5				
t_r	Rise Time		17		ns	$V_{DD} = 400\text{ V}, I_D = 5\text{ A}, R_G = 10\text{ }\Omega, V_{GS} = -5/18\text{ V}$	
$t_{d(off)}$	Turn-Off Delay Time		8				
t_f	Fall Time		10				

Reverse SiC Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.0		V	$V_{GS} = -4\text{ V}, I_{SD} = 2.5\text{ A}, T_J = 25^\circ\text{C}$	Fig. 16
		3.6			$V_{GS} = -4\text{ V}, I_{SD} = 2.5\text{ A}, T_J = 175^\circ\text{C}$	Fig. 17
$*I_{SD}$	Continuous Diode Forward Current		15	A	$TC = 25^\circ\text{C}$	
			12		$TC = 175^\circ\text{C}$	
t_{rr}	Reverse Recovery Time	50		ns	$I_{SD} = 5\text{ A}, di/dt = 1000\text{ A}/\mu\text{s}, V_{DD} = 400\text{ V}, V_{GS} = -5\text{ V}$	
Q_{rr}	Reverse Recovery Charge	38		nC		
I_{RRM}	Peak Reverse Recovery Current	2.4		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
R_{thJC}	Thermal Resistance from Junction to Case	2.88	$^\circ\text{C}/\text{W}$		Fig. 2
R_{thJA}	Thermal Resistance From Junction to Ambient	40			

Typical Characteristics

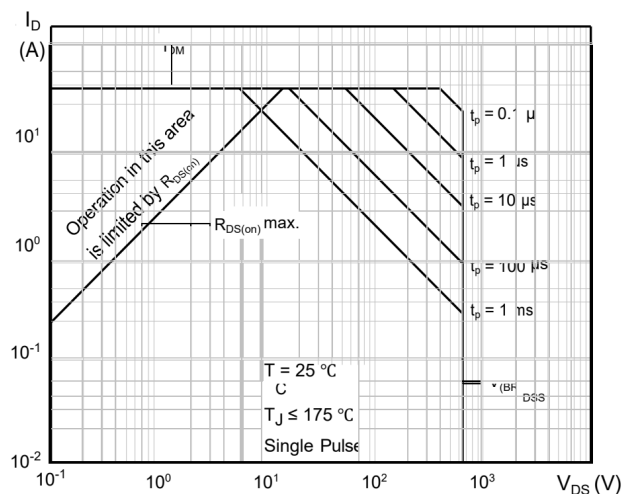


Figure 1. Safe Operating Area

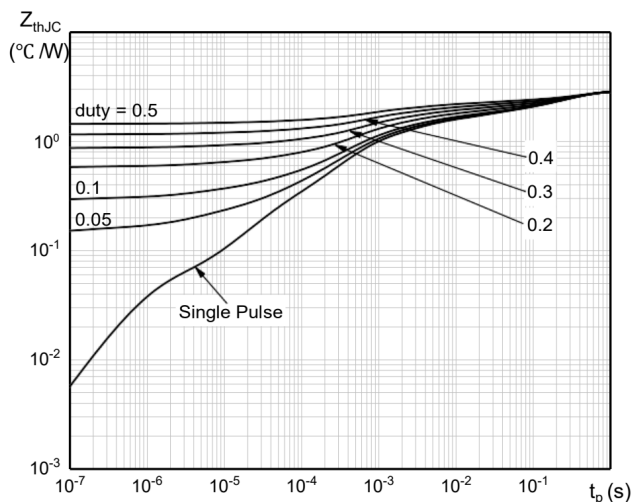


Figure 2. Maximum Transient Thermal Impedance

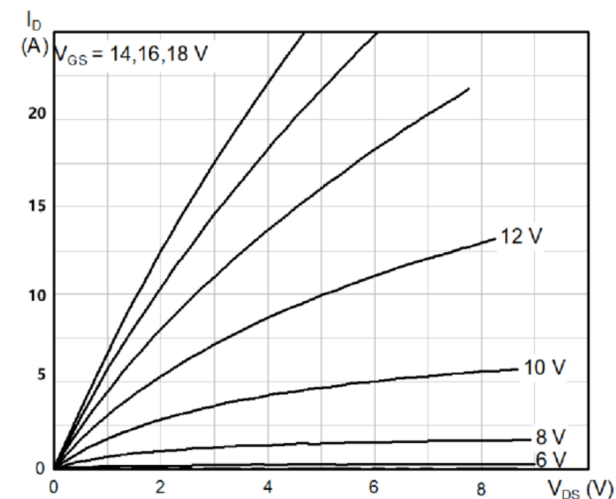


Figure 3. Typical Output Characteristics, $T_J = 25^\circ\text{C}$

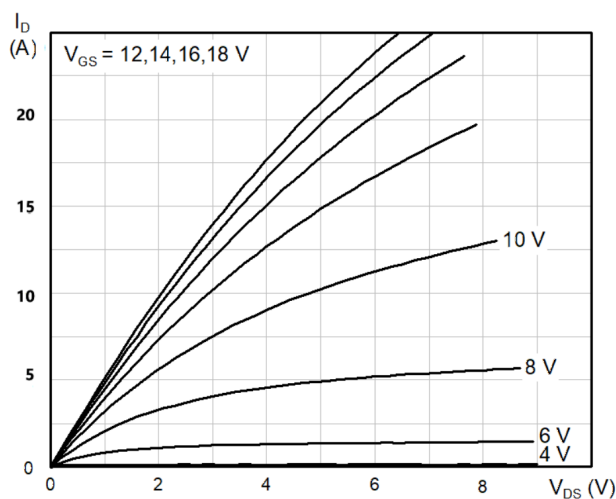


Figure 4. Typical Output Characteristics, $T_J = 175^\circ\text{C}$

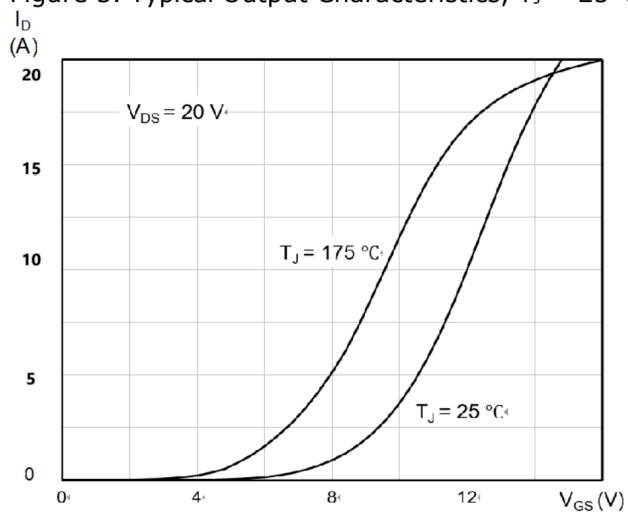


Figure 5. Typical Transfer Characteristics

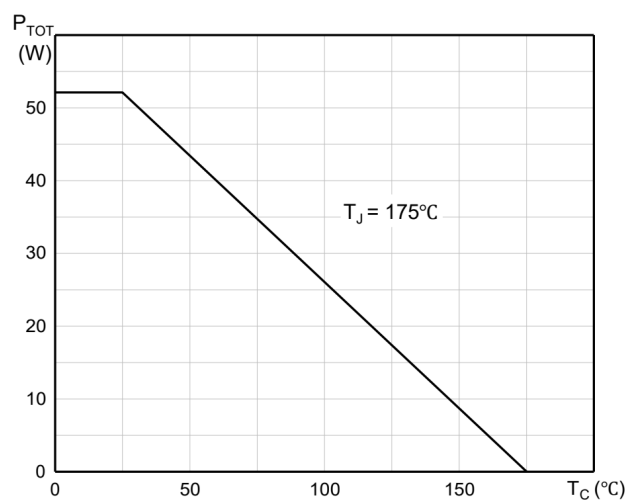


Figure 6. Total Power Dissipation

Figure 5. Typical Transfer Characteristics

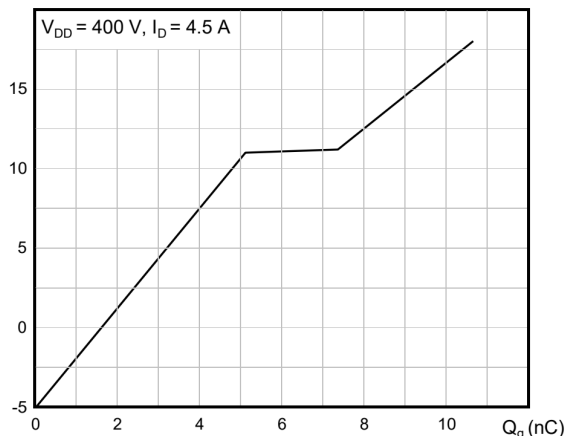


Figure 7. Typical Gate Charge Characteristics

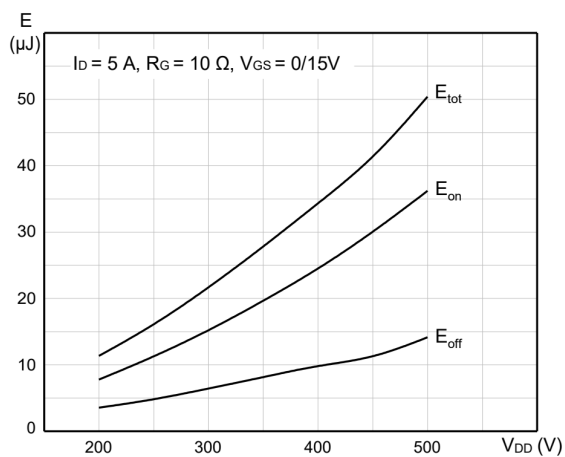


Figure 9. Typical Switching Energy vs. Supply Voltage

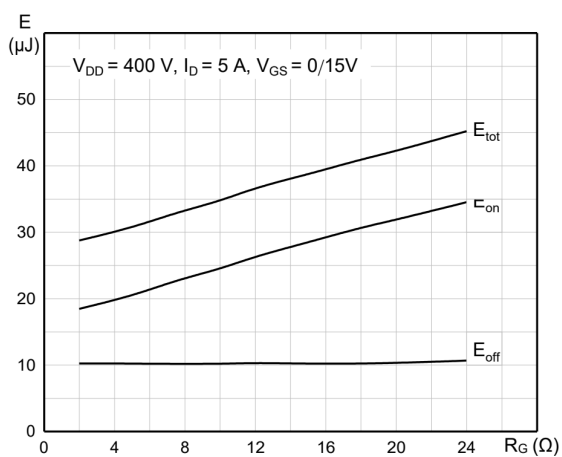


Figure 11. Switching Energy vs. Gate Resistance



Figure 6. Total Power Dissipation

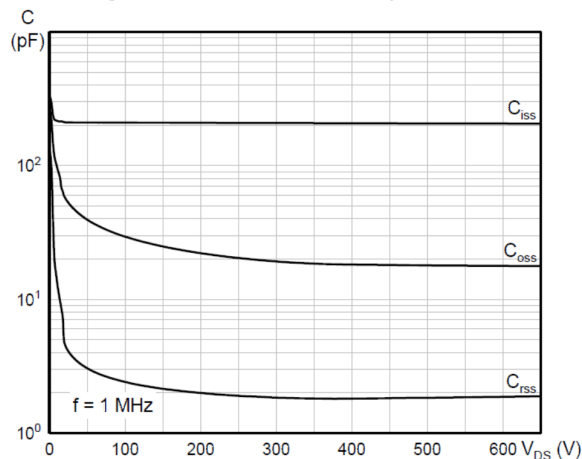


Figure 8. Typical Capacitance Characteristics

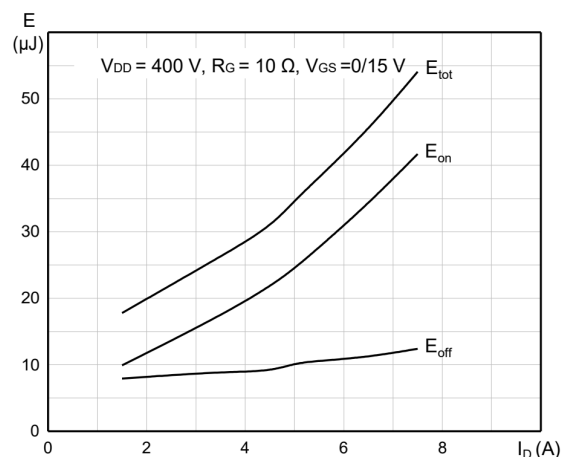


Figure 10. Typical Switching Energy vs. Drain Current

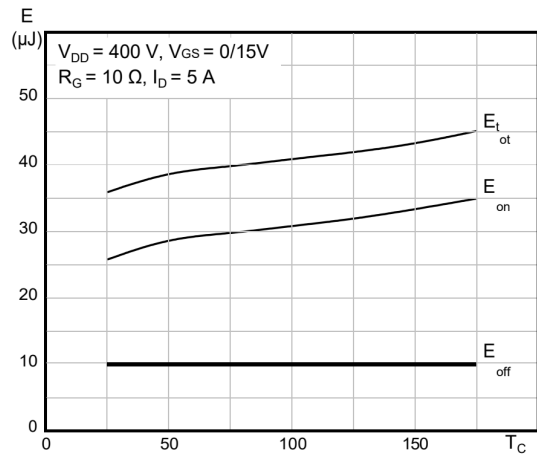


Figure 12. Typical Switching Energy vs. Temperature



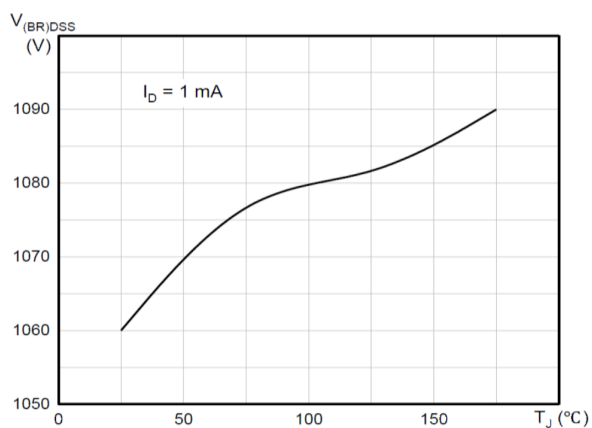


Figure 13. Breakdown Voltage vs. Temperature

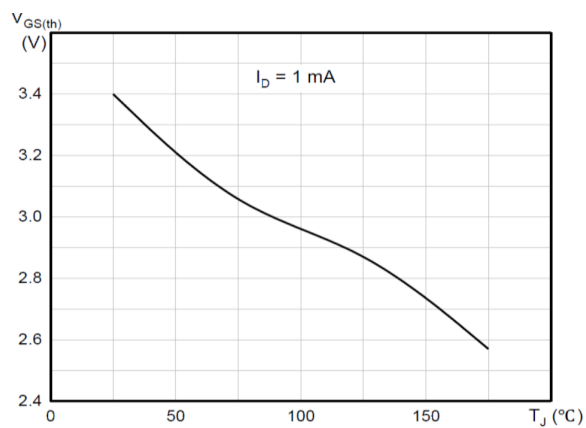


Figure 14. Gate Threshold vs. Temperature

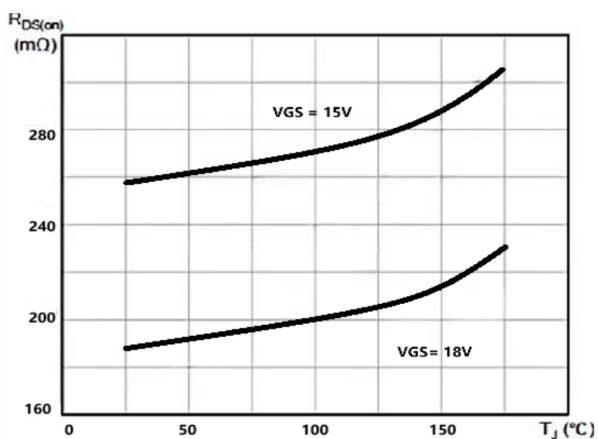


Figure 15. On-Resistance vs. Temperature

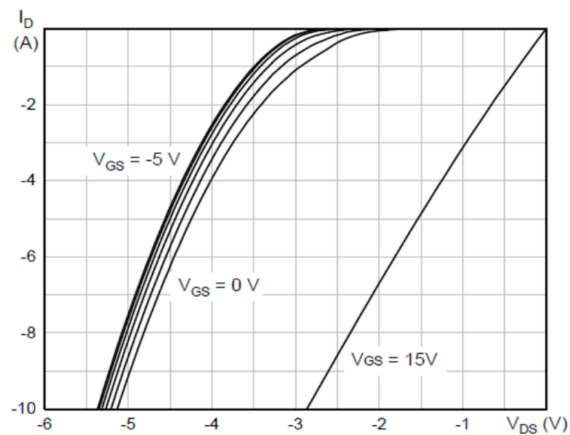


Figure 16. Body Diode Characteristics, $T_J = 25^{\circ}\text{C}$

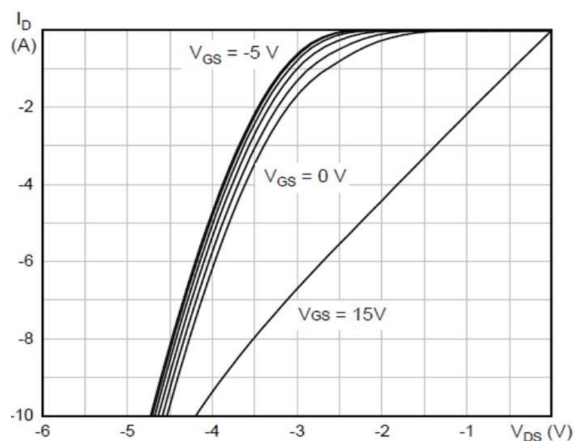


Figure 17. Body Diode Characteristics, $T_J = 175^{\circ}\text{C}$

Package Outline Dimension: PDFN 5×6

Technical drawing of a package showing top, side, and bottom views with dimensions:

- Top View:** Dimensions L1 (total length), L2 (lead length), L (lead width), and C (lead thickness). A circular feature is shown on the right side.
- Side View:** Dimensions A (height), C1 (lead thickness), and C2 (lead height).
- Bottom View:** Dimensions B (lead width), E (lead height), and R (lead angle).

Dim.	Min.	Max.
A	4.8	5.2
B	0.25	0.35
C	1.0	1.2
C1	Typ 0.254	
C2	Typ 0.254	
E	Typ 1.27	
L	6.0	6.3
L1	5.7	6.0
L2	MAX 0.2	
R	Typ 13°	

All Dimensions in millimeter

Revision History

Revision	Date of Release	Description of Changes
Preliminary	16.Sep.2025	Initial Release with NMC

Information

For further information on technology, delivery terms and conditions and prices, please contact SUPSiC.

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